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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Chun-Yu LIN, et al.

Serial No.: 10/004,629

Group No.: 2877

Filed: December 4, 2001

Examiner.:

For: METHOD AND SYSTEM FOR MEASURING MULTI-SEGMENT LED MODULES

Attorney Docket No.: U 013755-6

Commissioner for Patents
P.O. BOX 1450
ALEXANDRIA, VA. 22313

Sir:

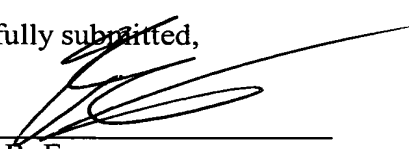
REQUEST FOR NEW ACTION

The Action of August 24, 2004, issued from Group 2625, which should have web-posted references in August 2004.

However, the attached copy of Patent Application Information Retrieval for August 27, 2004 shows that it did not.

Therefore, a new Action with references is requested.

Respectfully submitted,



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CERTIFICATE OF MAILING (37 CFR 1.8a)

I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal on the date shown below with sufficient postage as first class mail in an envelope addressed to the: Commissioner for Patents, P.O. BOX 1450, ALEXANDRIA, VA. 22313

Date: September 1, 2004

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PATENT APPLICATION INFORMATION RETRIEVAL

Search results as of: 8-27-2004::16:49:56 E.T.

Search results for application number: 10/004,629

	10/004,629		-
	12-04-2001		Non Final Action Mailed
	Utility		08-24-2004
Examiner Name:	CARTER, AARON W		ELECTRONIC
Group Art Unit:	2625	Location Date:	-
Confirmation Number:	6738	Earliest Publication No:	US 2002-0180955 A1
	U 013755-6	Earliest Publication Date:	12-05-2002
	382/145		-
	Chun-Yu Lin, Tainan, (TW)		-
	Method and system for measuring multi-segment LED modules		

Search Options

Foreign Priority
Image File Wrapper
Published Documents

File History

Date	Contents Description
08-24-2004	Mail Non-Final Rejection
08-20-2004	Non-Final Rejection
07-30-2004	Case Docketed to Examiner in GAU
03-05-2004	Case Docketed to Examiner in GAU
01-13-2004	IFW TSS Processing by Tech Center Complete
01-28-2002	Case Docketed to Examiner in GAU
12-04-2001	Request for Foreign Priority (Priority Papers May Be Included)
12-04-2001	Miscellaneous Incoming Letter
01-08-2002	Application Dispatched from OIPE
12-31-2001	Application Is Now Complete
12-14-2001	IFW Scan & PACR Auto Security Review
12-04-2001	Initial Exam Team nn